

OCTAL POSITIVE EDGE-TRIGGERED D-TYPE FLIP FLOP WITH RESET

DESCRIPTION

The M74LS273P is a semiconductor integrated circuit containing 8 D-type positive edge-triggered flip-flop circuits with common direct reset and clock inputs.

FEATURES

- Positive edge-triggering
- High mounting density with 8 circuits contained
- Direct reset and clock inputs common to all 8 circuits
- Wide operating temperature range ($T_a = -20 \sim +75^\circ\text{C}$)

APPLICATION

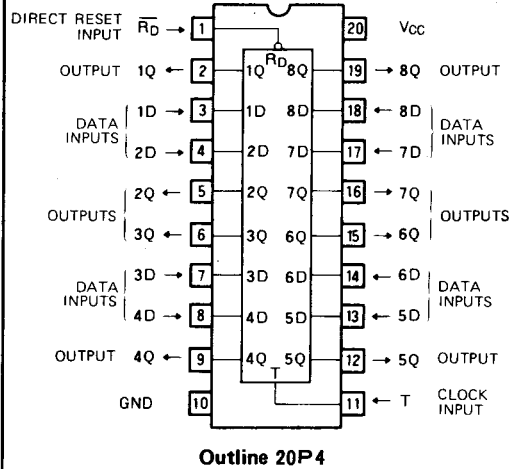
General purpose, for use in industrial and consumer equipment.

FUNCTIONAL DESCRIPTION

This device contains 8 edge-triggered D-type flip-flop circuits and it is provided with direct reset $\overline{R_D}$ input and clock input T common to all 8 circuits. When T changes in each flip-flop from low to high, the data input signal D immediately before the change appears in output Q.

When $\overline{R_D}$ is set low, 1Q through 8Q are all set low irrespective of the status of the 1D through 8D and T signals. For use as a D-type flip-flop, $\overline{R_D}$ must be kept in high.

PIN CONFIGURATION (TOP VIEW)



FUNCTION TABLE (Note 1)

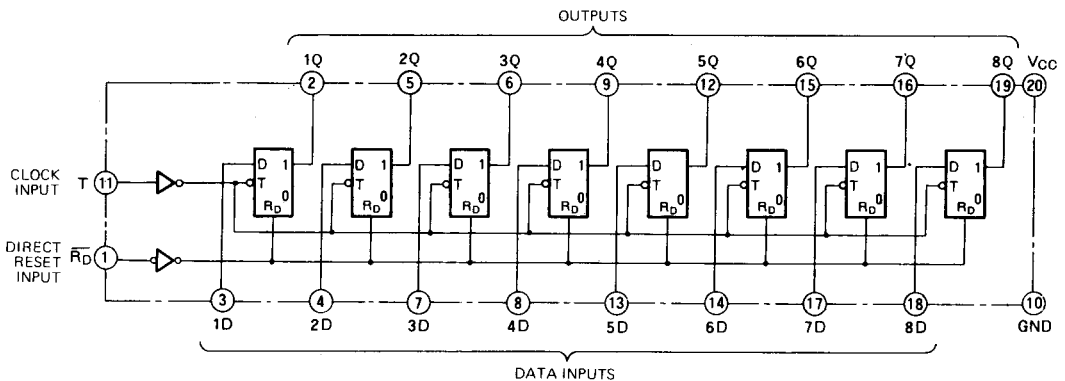
| $\overline{R_D}$ | T | D | Q |
|------------------|---|---|----------------|
| L | X | X | L |
| H | ↑ | H | H |
| H | ↑ | L | L |
| H | L | X | Q ₀ |

Note 1 ↑ : Transition from low to high (positive edge trigger)

Q₀ : Level of Q before the indicated steady-state input conditions were established.

X : Irrelevant

BLOCK DIAGRAM



OCTAL POSITIVE EDGE-TRIGGERED D-TYPE FLIP FLOP WITH RESET

ABSOLUTE MAXIMUM RATINGS (T_a = -20 ~ +75°C, unless otherwise noted)

| Symbol | Parameter | Conditions | Limits | Unit |
|------------------|--|------------------|------------------------|------|
| V _{CC} | Supply voltage | | -0.5 ~ +7 | V |
| V _I | Input voltage | | -0.5 ~ +15 | V |
| V _O | Output voltage | High-level state | -0.5 ~ V _{CC} | V |
| T _{opr} | Operating free-air ambient temperature range | | -20 ~ +75 | °C |
| T _{stg} | Storage temperature range | | -65 ~ +150 | °C |

RECOMMENDED OPERATING CONDITIONS (T_a = -20 ~ +75°C, unless otherwise noted)

| Symbol | Parameter | Limits | | | Unit |
|-----------------|---------------------------|------------------------|-----|------|------|
| | | Min | Typ | Max | |
| V _{CC} | Supply voltage | 4.75 | 5 | 5.25 | V |
| I _{OH} | High-level output current | V _{OH} ≥ 2.7V | 0 | -400 | μA |
| I _{OL} | Low-level output current | V _{OL} ≤ 0.4V | 0 | 4 | mA |
| | | V _{OL} ≤ 0.5V | 0 | 8 | mA |

ELECTRICAL CHARACTERISTICS (T_a = -20 ~ +75°C, unless otherwise noted)

| Symbol | Parameter | Test conditions | Limits | | | Unit |
|-----------------|---------------------------------------|---|--------|-------|------|------|
| | | | Min | Typ * | Max | |
| V _{IH} | High-level input voltage | | 2 | | | V |
| V _{IL} | Low-level input voltage | | | | 0.8 | V |
| V _{IC} | Input clamp voltage | V _{CC} = 4.75V, I _{IC} = -18mA | | | -1.5 | V |
| V _{OH} | High-level output voltage | V _{CC} = 4.75V, V _I = 0.8V V _I = 2V, I _{OH} = -400μA | 2.7 | 3.4 | | V |
| V _{OL} | Low-level output voltage | V _{CC} = 4.75V, I _{OL} = 4mA | | 0.25 | 0.4 | V |
| | | V _I = 0.8V, V _I = 2V, I _{OL} = 8mA | | 0.35 | 0.5 | V |
| I _{IH} | High-level input current | V _{CC} = 5.25V, V _I = 2.7V | | | 20 | μA |
| | | V _{CC} = 5.25V, V _I = 10V | | | 0.1 | mA |
| I _{IL} | Low-level input current | V _{CC} = 5.25V, V _I = 0.4V | | | -0.4 | mA |
| I _{OS} | Short-circuit output current (Note 2) | V _{CC} = 5.25V, V _O = 0V | -20 | | -100 | mA |
| I _{CC} | Supply current | V _{CC} = 5.25V (Note 3) | | 17 | 27 | mA |

* All typical values are at V_{CC} = 5V, T_a = 25°C

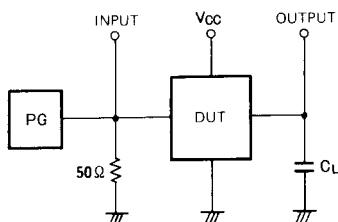
Note 2: All measurements should be done quickly, and not more than one output should be shorted at a time.

Note 3: I_{CC} is measured after 1D ~ 8D and \overline{RD} are made 4.5V and T has been changed from 0V to 4.5V.

SWITCHING CHARACTERISTICS (V_{CC} = 5V, T_a = 25°C, unless otherwise noted)

| Symbol | Parameter | Test conditions | Limits | | | Unit |
|------------------|---|---------------------------------|--------|-----|-----|------|
| | | | Min | Typ | Max | |
| f _{max} | Maximum clock frequency | C _L = 15 pF (Note 4) | 30 | 40 | | MHz |
| t _{PLH} | Low-to-high-level, high-to-low-level output propagation time, from T to 1Q~8Q | | | 12 | 27 | ns |
| t _{PHL} | High-to-low-level output propagation time, from \overline{RD} to 1Q~8Q | | | 13 | 27 | ns |
| t _{PHL} | High-to-low-level output propagation time, from \overline{RD} to 1Q~8Q | | | 15 | 27 | ns |

Note 4: Measurement circuit



(1) The pulse generator (PG) has the following characteristics:

PRR = 1MHz, t_r = 6ns, t_f = 6ns, t_w = 500ns, V_p = 3V_{p-p}, Z₀ = 50Ω.

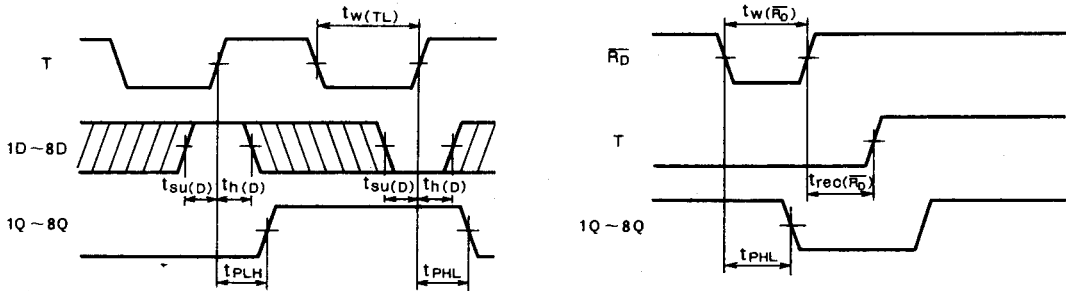
(2) C_L includes probe and jig capacitance.

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TIMING REQUIREMENTS ($V_{CC}=5V$, $T_a=25^{\circ}C$, unless otherwise noted)

| Symbol | Parameter | Test conditions | Limits | | | Unit |
|---------------------|-------------------------------|-----------------|--------|-----|-----|------|
| | | | Min | Typ | Max | |
| $t_w(TL)$ | Clock input T low pulse width | | 20 | 7 | | ns |
| $t_w(R\bar{D})$ | Direct reset pulse width | | 20 | 6 | | ns |
| $t_{su}(D)$ | Setup time $1D \sim 8D$ to T | | 20 | 7 | | ns |
| $t_h(D)$ | Hold time $1D \sim 8D$ to T | | 5 | -3 | | ns |
| $t_{rec}(R\bar{D})$ | Recovery time $R\bar{D}$ to T | | 25 | 8 | | ns |

TIMING DIAGRAM (Reference level = 1.3V)



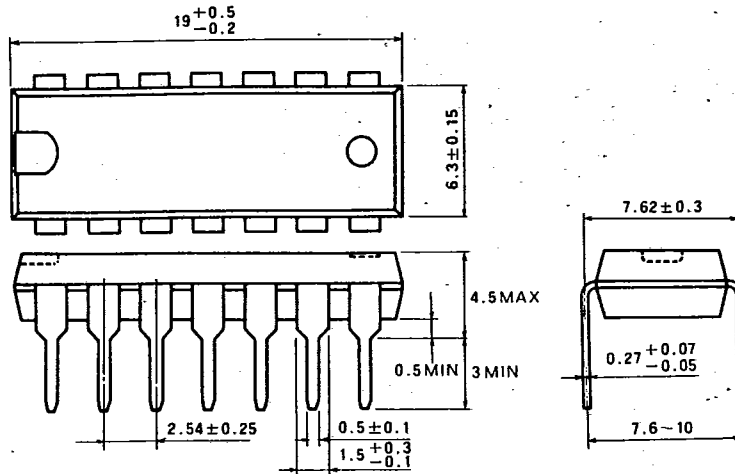
Note 5: The shaded areas indicate when the input is permitted to change for predictable output performance.

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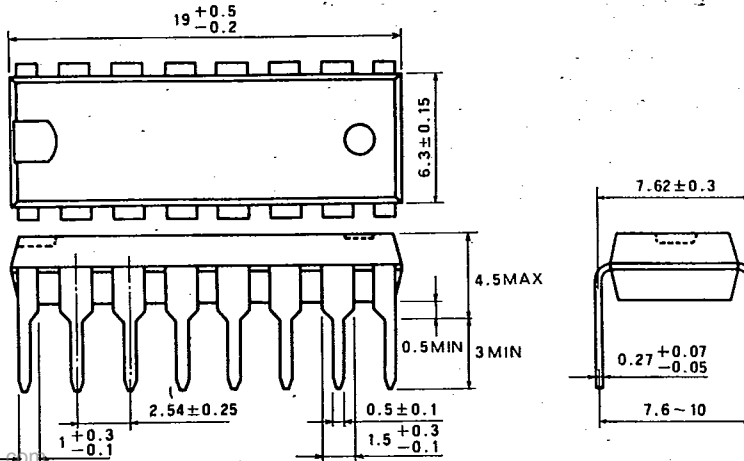
TYPE 14P4 14-PIN MOLDED PLASTIC DIL

Dimension in mm



TYPE 16P4 16-PIN MOLDED PLASTIC DIL

Dimension in mm



TYPE 20P4 20-PIN MOLDED PLASTIC DIL

Dimension in mm

